

Insulation resistance (EN 61557-2)	
Meas. ranges (MΩ):	R: 0.25 MΩ ÷ 199.9 MΩ, U _N =50 V~, 100 V~, 250 V~ R: 0.15 MΩ ÷ 999 MΩ, U _N = 500 V~, 1 kV~ U: 0 V~ ÷ 1200 V~
Nominal voltages:	100 V~, 250 V~, 500 V~, 1 kV ~
Measuring current:	min.1 mA~ at R _N =U _N ×1 kΩ/V
Short-circuit current:	<3 mA~
Continuity	
R Low Ω (EN 61557-4)	
Meas. ranges (Ω):	R: 0.16 Ω ÷ 1999 Ω
Test current:	min. ±200 mA~ at 2 Ω
Open-circuit voltage:	6.5 V~ ÷ 9.0 V~
Continuity 7mA	
Meas. ranges (Ω):	R: 0.0 Ω ÷ 1999 Ω
Test current:	max. 8.5 mA ~
Open-circuit voltage:	6.5 V~ ÷ 9.0 V~
Line impedance (EN 61557-3)	
Meas. ranges (Ω):	R _{L-N(L)} : 0.25 Ω ÷ 19.9k Ω
I _{PECC} :	calculated value
Nominal voltage:	30 V ÷ 500 V / 15 Hz ÷ 500 Hz
Fault loop impedance (EN 61557-3)	
Meas. ranges (Ω):	R _{L-PE} : 0.25 Ω ÷ 19999 Ω
I _{PECC} :	calculated value
Nominal voltage:	50 V ÷ 500 V/ 15 Hz ÷ 500 Hz
Voltage, frequency	
U:	0V ÷ 550 V / f: 15 Hz ÷ 500 Hz
Phase rotation (EN 61557-7)	
Nominal voltage:	100 V ÷ 550 V / 15 Hz ÷ 500 Hz
Results:	1.2.3 or 2.1.3
RCD (EN 61557-6)	
Meas. range (IΔN):	10 mA, 30 mA, 100 mA, 300 mA, 500 mA, 1 A
Nominal voltage:	50 V ÷ 264 V/ 15 Hz ÷ 500 Hz
Contact voltage UC	
UC:	20.0 V~ ÷ 31.0 V(62.0) V~
for UC _{lim} :	25 V (50 V)
Tripping time	
non-delayed	
(time-delayed) RCDs	×1: 0 ms ÷ 300 ms (500 ms) ×2 : 0 ms ÷ 150 ms (200 ms) ×5 : 0 ms ÷ 40 ms (150 ms), UC: 0.0 V ÷ 99.9 V
Tripping current	
	IΔ: 0.2 × IΔN ÷ 1.1 × IΔN AC (÷1.5 × IΔN A) tΔ: 0 ms ÷ 300 ms, UC: 0.0 V~ ÷ 100.0 V~
Multiplier:	×0.5, ×1, ×2, ×5
Resistance to earth (EN 61557-5)	
R:	0,67 Ω ÷ 9999 Ω
Open-circuit voltage:	< 45 V _{RMS}
Short-circuit current:	< 20 mA
REARTH ∞	
R:	0.0 Ω÷9999 Ω
REARTH ∞ ∞	
R:	0.0 Ω÷99 Ω
Illumination	
E:	0.00lux÷19.99klux
TRMS current	
I:	0.0mA÷19.99A